

Inermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	Б	70	90	°C/W				
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	κ <sub>θJA</sub>	100	125	°C/W				
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{ ext{ heta}JL}$	63	80	°C/W				

## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		30			V
I <sub>DSS</sub> Zero	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V				1	μA
			T <sub>J</sub> =55°C			5	μΛ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±16V				10	uA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$		1	1.32	1.8	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V		30			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =4.2A			43	52	mΩ
			T <sub>J</sub> =125°C		58	74	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =2A			59	75	mΩ
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =4.2A			8.5		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.77	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Curr	s Current				1.8	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			269	340	pF
C <sub>oss</sub>	Output Capacitance				65		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				41		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			1	1.5	Ω
SWITCHI	NG PARAMETERS				-		
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =4.2A			5.7	7.2	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				3		nC
Q <sub>gs</sub>	Gate Source Charge				1.37		nC
$Q_{gd}$	Gate Drain Charge				0.65		nC
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =3.6Ω, R <sub>GEN</sub> =3Ω			2.6	3.8	ns
t <sub>r</sub>	Turn-On Rise Time				5.5	8	ns
t <sub>D(off)</sub>	Turn-Off DelayTime				15.2	23	ns
t <sub>f</sub>	Turn-Off Fall Time				3.7	5.5	ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =4.2A, dl/dt=100A/μs			15.5	21	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =4.2A, dI/dt=100A/μs			7.1		nC

A: The value of R  $_{0.1A}$  is measured with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T  $_{A}$ =25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\rm 0JA}$  is the sum of the thermal impedence from junction to lead R  $_{\rm 0JL}$  and lead to ambient.

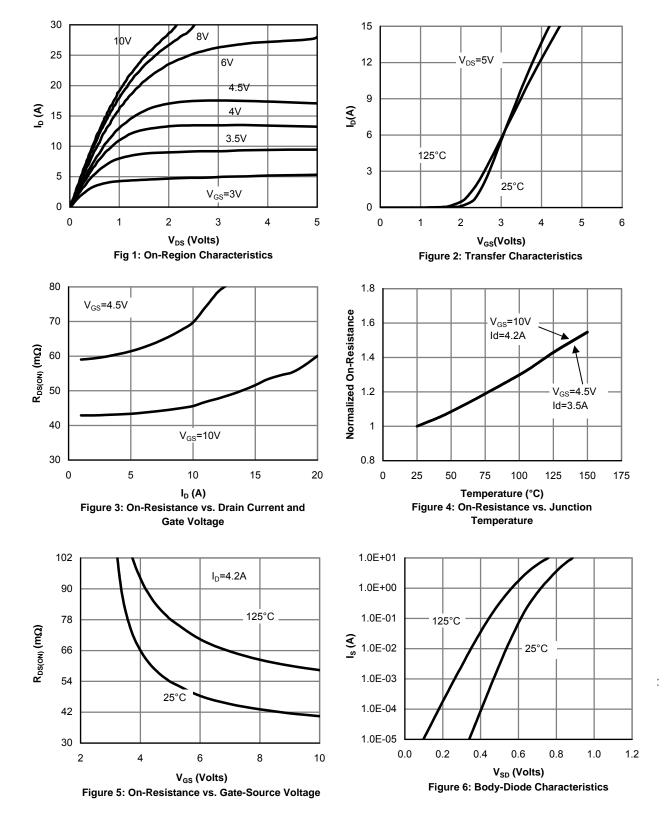
D. The static characteristics in Figures 1 to 6 are obtained using <300  $\,\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in  ${}^{2}$  FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F.The current rating is based on the t ${\leqslant}10s$  thermal resistance rating.

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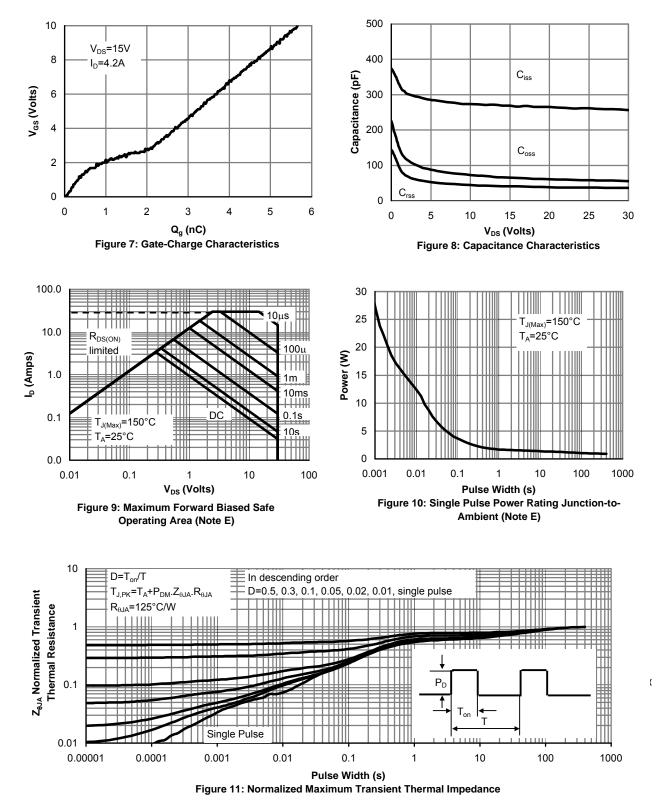
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